

## Multi-Crystal Type Transverse Section Scanning Device

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**Purpose:** The purpose of Multi-Crystal Type Transverse Section Scanning Device is to obtain three dimensional RI position information having good accuracy and sensitivity by obtaining transverse RI distribution image by moving scintillation detectors round the object or RI distribution image on four sides of the object at the same time by performing lateral scanning.

**Method:** Four pieces of multi-crystal type NaI detectors are arranged around the object. Each detector is composed of fifteen pieces of scintillators placed in a straight line and eight pieces of PMT's, and the position of scintillator where an event occurs is taken out as one dimensional digital position signal. Rotation angle signal and the one dimensional position signal obtained by rotating these detectors round the object at constant speed are calculated with electronic circuit, and the

image of RI distributed on the section perpendicular to rotation axis is displayed on CRT. Sixty digital position signals are obtained with the four detectors by shifting the detectors 1/4 of the width of scintillator. Collimator is provided with holes focussed on the section perpendicular to rotation axis so as to obtain thin transverse image.

The object is slidden inside the four detectors by moving the table at constant speed in the direction perpendicular to the plane on which the detectors are arranged. RI distribution images on four sides of the object are displayed at the same time on CRT processing electronically the scanning signal of this table and the scintillation position signals of the four detectors.

**Conclusion:** Three dimensional information of RI distribution is obtained with good accuracy and high sensitivity.

## Experimental Study on Transverse Section Scintigraphy

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Some phantom experiments on a new method of taking transverse section scintigraphy was described, using a specially made CRT of rotating type and Anger type camera. A rotating table for a patient is prepared, which is set so as to be that the rotation center of rotating table should be

placed within perpendicular line of the center of the detector facing sideways. A rotating tube rotates synchronously with rotation of the CRT coil. The resolving power of transverse section image in a new CRT was moderately better than that by former CRT.